

Notice of References Cited	Application/Control No. 10/630,983	Applicant(s)/Patent Under Reexamination KOIKE, HIDEHARU	
	Examiner Hai L. Nguyen	Art Unit 2816	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,867,629 B2	03-2005	Drost et al.	327/270
X	B	US-6,121,812 A	09-2000	Tsukikawa, Yasuhiko	327/280
X	C	US-5,459,424 A	10-1995	Hattori, Shinji	327/278
X	D	US-5,097,159 A	03-1992	Seki et al.	327/263
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.